

# IRFN450 (JANTX2N7228U)

PD-90418D

**Power MOSFET**

**Surface Mount (SMD-1)**

**500V, 12A, N-channel, HEXFET™ MOSFET Technology**

## Features

- Simple drive requirements
- Hermetically sealed
- Electrically isolated
- Surface mount
- Dynamic dv/dt rating
- Light weight

## Product Summary

- $BV_{DSS}$ : 500V
- $I_D$ : 12A
- $R_{DS(on),max}$ : 415mΩ
- $Q_{G,max}$ : 120nC
- **REF:** MIL-PRF-19500/592



## Potential Applications

- DC-DC converter
- Motor drives

## Product Validation

Qualified to JANTXV screening flow according to MIL-PRF-19500 for high-reliability applications

## Description

IR HiRel HEXFET™ technology is advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET™ transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, fast switching and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET™ transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

## Ordering Information

**Table 1 Ordering options**

| Part number   | Package | Screening Level |
|---------------|---------|-----------------|
| IRFN450       | SMD-1   | COTS            |
| JANTX2N7228U  | SMD-1   | JANTX           |
| JANTXV2N7228U | SMD-1   | JANTXV          |

**Table of contents****Table of contents**

|  |           |
|--|-----------|
| <b>Features .....</b>  | <b>1</b>  |
| <b>Potential Applications.....</b>                             | <b>1</b>  |
| <b>Product Validation.....</b>                                 | <b>1</b>  |
| <b>Description .....</b>                                       | <b>1</b>  |
| <b>Ordering Information.....</b>                               | <b>1</b>  |
| <b>Table of contents.....</b>                                  | <b>2</b>  |
| <b>1    Absolute Maximum Ratings .....</b>                     | <b>3</b>  |
| <b>2    Device Characteristics .....</b>                       | <b>4</b>  |
| 2.1       Electrical Characteristics .....                     | 4         |
| 2.2       Source-Drain Diode Ratings and Characteristics ..... | 5         |
| 2.3       Thermal Characteristics .....                        | 5         |
| <b>3    Electrical Characteristics Curves.....</b>             | <b>6</b>  |
| <b>4    Test Circuits .....</b>                                | <b>9</b>  |
| <b>5    Package Outline.....</b>                               | <b>10</b> |
| <b>Revision history.....</b>                                   | <b>11</b> |

**Absolute Maximum Ratings****1 Absolute Maximum Ratings****Table 2 Absolute Maximum Ratings**

| <b>Symbol</b>                                   | <b>Parameter</b>                                 | <b>Value</b>                              | <b>Unit</b>   |
|---|--|---|---------------|
| $I_{D1}$ @ $V_{GS} = 10V$ , $T_C = 25^\circ C$  | Continuous Drain Current                         | 12  | A             |
| $I_{D2}$ @ $V_{GS} = 10V$ , $T_C = 100^\circ C$ | Continuous Drain Current                         | 8.0                                       | A             |
| $I_{DM}$ @ $T_C = 25^\circ C$                   | Pulsed Drain Current <sup>1</sup>                | 48  | A             |
| $P_D$ @ $T_C = 25^\circ C$                      | Maximum Power Dissipation                        | 150                                       | W             |
|   | Linear Derating Factor                           | 1.2                                       | W/ $^\circ C$ |
| $V_{GS}$  | Gate-to-Source Voltage                           | $\pm 20$                                  | V             |
| $E_{AS}$  | Single Pulse Avalanche Energy <sup>2</sup>       | 750                                       | mJ            |
| $I_{AR}$  | Avalanche Current <sup>1</sup>                   | 12  | A             |
| $E_{AR}$  | Repetitive Avalanche Energy <sup>1</sup>         | 15  | mJ            |
| $dv/dt$   | Peak Diode Reverse Recovery <sup>3</sup>         | 3.5                                       | V/ns          |
| $T_J$<br>$T_{STG}$                              | Operating Junction and Storage Temperature Range | -55 to +150                               | $^\circ C$    |
|   | Lead Temperature                                 | 300 (0.063 in. /1.6 mm from case for 10s) |               |
|   | Weight   | 2.6 (Typical)                             | g             |

<sup>1</sup> Repetitive Rating; Pulse width limited by maximum junction temperature.<sup>2</sup>  $V_{DD} = 25V$ , starting  $T_J = 25^\circ C$ ,  $L = 10.4mH$ , Peak  $I_L = 12A$ ,  $V_{GS} = 10V$ <sup>3</sup>  $I_{SD} \leq 12A$ ,  $di/dt \leq 130A/\mu s$ ,  $V_{DD} \leq 500V$ ,  $T_J \leq 150^\circ C$

## Device Characteristics

## 2 Device Characteristics

## 2.1 Electrical Characteristics

**Table 3 Electrical Characteristics @  $T_j = 25^\circ\text{C}$  (Unless Otherwise Specified)**

| Symbol                                     | Parameter                                  | Min. | Typ. | Max. | Unit                | Test Conditions   |
|--|--|------|------|------|---------------------|---|
| $\text{BV}_{\text{DSS}}$                   | Drain-to-Source Breakdown Voltage          | 500  | —    | —    | V                   | $\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 1.0\text{mA}$                                   |
| $\Delta \text{BV}_{\text{DSS}}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient        | —    | 0.68 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}, \text{I}_D = 1.0\text{mA}$                                      |
| $R_{\text{DS}(\text{on})}$                 | Static Drain-to-Source On-State Resistance | —    | —    | 415  | $\text{m}\Omega$    | $\text{V}_{\text{GS}} = 10\text{V}, \text{I}_{D2} = 8.0\text{A}$ <sup>1</sup>                   |
|  |  | —    | —    | 515  |                     | $\text{V}_{\text{GS}} = 10\text{V}, \text{I}_{D1} = 12\text{A}$ <sup>1</sup>                    |
| $\text{V}_{\text{GS}(\text{th})}$          | Gate Threshold Voltage                     | 2.0  | —    | 4.0  | V                   | $\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$                      |
| $G_{\text{fs}}$                            | Forward Transconductance                   | 6.5  | —    | —    | S                   | $\text{V}_{\text{DS}} = 15\text{V}, \text{I}_{D2} = 8.0\text{A}$                                |
| $I_{\text{DSS}}$                           | Zero Gate Voltage Drain Current            | —    | —    | 25   | $\mu\text{A}$       | $\text{V}_{\text{DS}} = 400\text{V}, \text{V}_{\text{GS}} = 0\text{V}$                          |
|  |  | —    | —    | 250  |                     | $\text{V}_{\text{DS}} = 400\text{V}, \text{V}_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$ |
| $I_{\text{GSS}}$                           | Gate-to-Source Leakage Forward             | —    | —    | 100  | nA                  | $\text{V}_{\text{GS}} = 20\text{V}$   |
|  | Gate-to-Source Leakage Reverse             | —    | —    | -100 |                     | $\text{V}_{\text{GS}} = -20\text{V}$  |
| $Q_G$                                      | Total Gate Charge                          | —    | —    | 120  | nC                  | $I_{D1} = 12\text{A}$   |
| $Q_{\text{GS}}$                            | Gate-to-Source Charge                      | —    | —    | 19   |                     | $\text{V}_{\text{DS}} = 250\text{V}$  |
| $Q_{\text{GD}}$                            | Gate-to-Drain ('Miller') Charge            | —    | —    | 70   |                     | $\text{V}_{\text{GS}} = 10\text{V}$   |
| $t_{d(\text{on})}$                         | Turn-On Delay Time                         | —    | —    | 35   | ns                  | $I_{D1} = 12\text{A}$ **  |
| $t_r$                                      | Rise Time                                  | —    | —    | 190  |                     | $\text{V}_{\text{DD}} = 250\text{V}$  |
| $t_{d(\text{off})}$                        | Turn-Off Delay Time                        | —    | —    | 170  |                     | $R_G = 2.35\Omega$  |
| $t_f$                                      | Fall Time                                  | —    | —    | 130  |                     | $\text{V}_{\text{GS}} = 10\text{V}$   |
| $L_s + L_D$                                | Total Inductance                           | —    | 4.0  | —    | nH                  | Measured from the center of drain pad to center of source pad.                                  |
| $C_{\text{iss}}$                           | Input Capacitance                          | —    | 2700 | —    | pF                  | $\text{V}_{\text{GS}} = 0\text{V}$  |
| $C_{\text{oss}}$                           | Output Capacitance                         | —    | 600  | —    |                     | $\text{V}_{\text{DS}} = 25\text{V}$   |
| $C_{\text{rss}}$                           | Reverse Transfer Capacitance               | —    | 240  | —    |                     | $f = 1.0\text{MHz}$   |

\*\* Switching speed maximum limits are based on manufacturing test equipment and capability.

<sup>1</sup> Pulse width  $\leq 300\ \mu\text{s}$ ; Duty Cycle  $\leq 2\%$

## Device Characteristics

## 2.2 Source-Drain Diode Ratings and Characteristics

Table 4 Source-Drain Diode Characteristics

| Symbol   | Parameter                                       | Min.  | Typ. | Max. | Unit          | Test Conditions   |
|----------|---|---|------|------|---------------|---|
| $I_S$    | Continuous Source Current (Body Diode)          | —   | —    | 12   | A             |   |
| $I_{SM}$ | Pulsed Source Current (Body Diode) <sup>1</sup> | —   | —    | 48   | A             |   |
| $V_{SD}$ | Diode Forward Voltage                           | —   | —    | 1.7  | V             | $T_J = 25^\circ\text{C}$ , $I_S = 12\text{A}$ , $V_{GS} = 0\text{V}$ <sup>2</sup>                             |
| $t_{rr}$ | Reverse Recovery Time                           | —   | —    | 1600 | ns            | $T_J = 25^\circ\text{C}$ , $I_F = 12\text{A}$ , $V_{DD} \leq 30\text{V}$<br>$dI/dt = 100\text{A}/\mu\text{s}$ |
| $Q_{rr}$ | Reverse Recovery Charge                         | —   | 9.3  | —    | $\mu\text{C}$ |   |
| $t_{on}$ | Forward Turn-On Time                            | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |               |   |

## 2.3 Thermal Characteristics

Table 5 Thermal Resistance

| Symbol             | Parameter   | Min. | Typ. | Max. | Unit                      |
|--------------------|---|------|------|------|---------------------------|
| $R_{\theta JC}$    | Junction-to-Case  | —    | —    | 0.83 | $^\circ\text{C}/\text{W}$ |
| $R_{\theta J-PCB}$ | Junction-to-PC board (Soldered to a copper-clad PC board) | —    | 3.0  | —    |                           |

<sup>1</sup> Repetitive Rating; Pulse width limited by maximum junction temperature.<sup>2</sup> Pulse width  $\leq 300\ \mu\text{s}$ ; Duty Cycle  $\leq 2\%$

### 3 Electrical Characteristics Curves

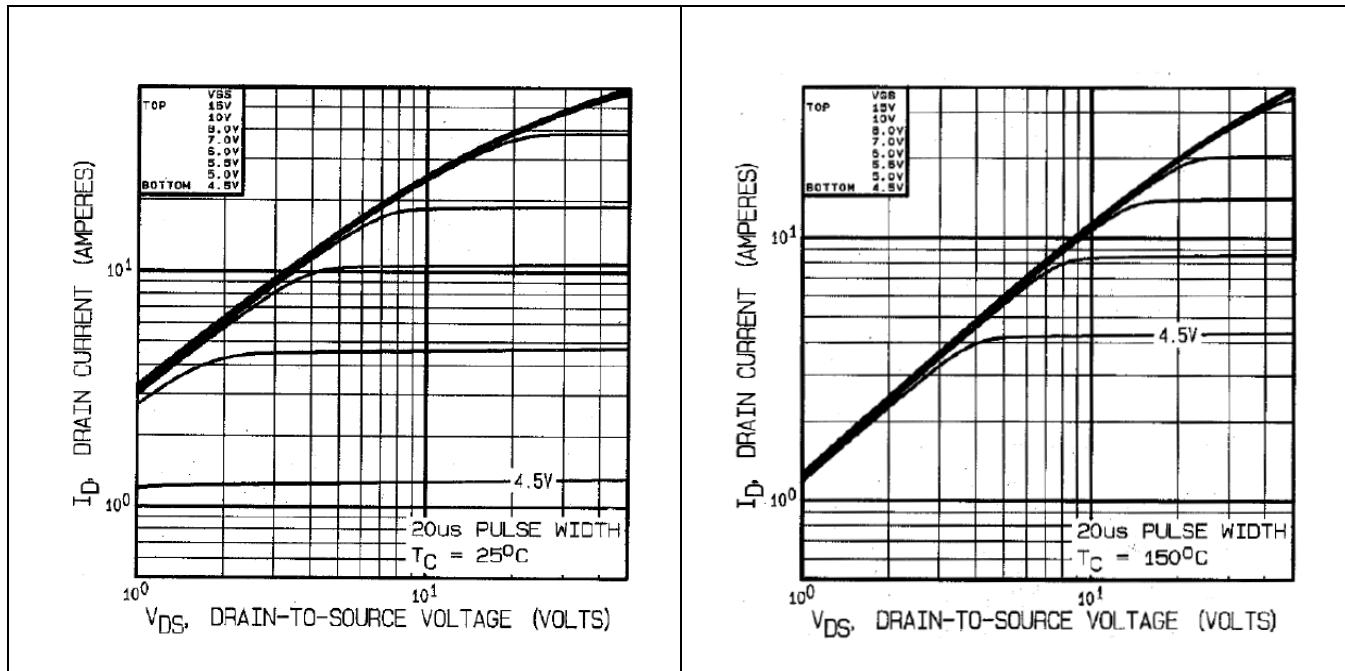


Figure 1 Typical Output Characteristics

Figure 2 Typical Output Characteristics

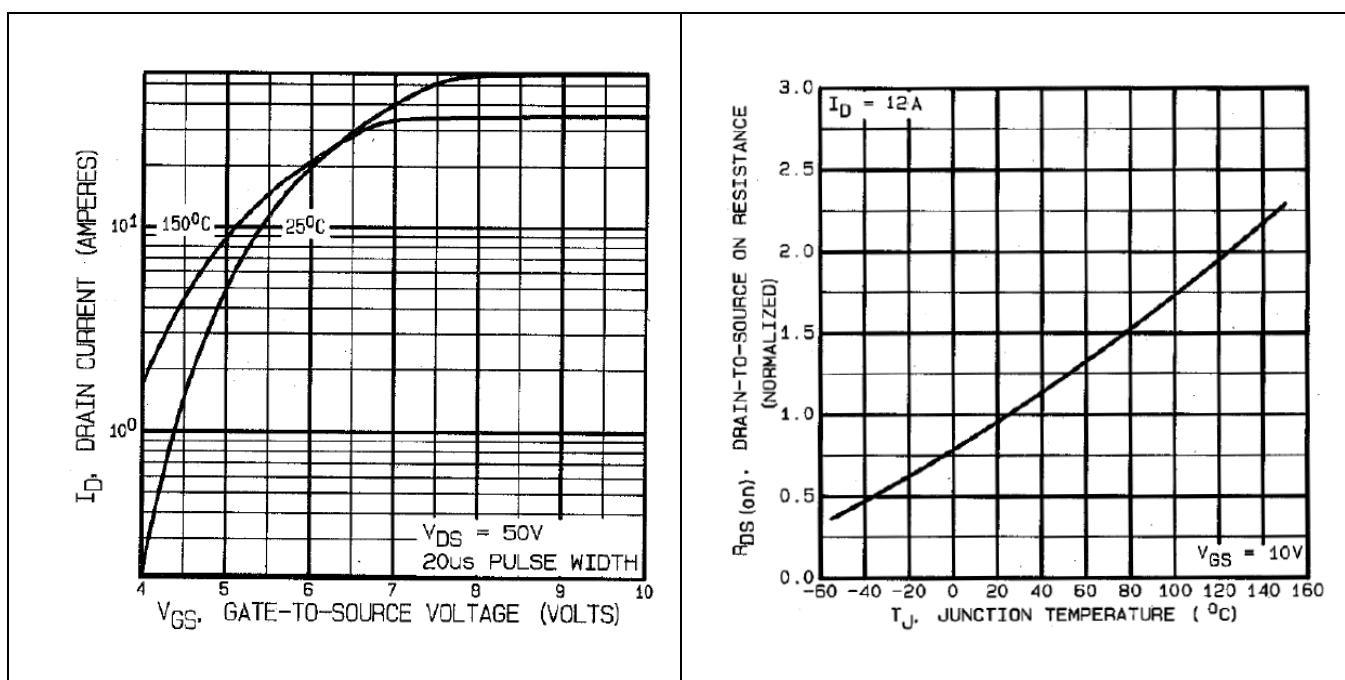
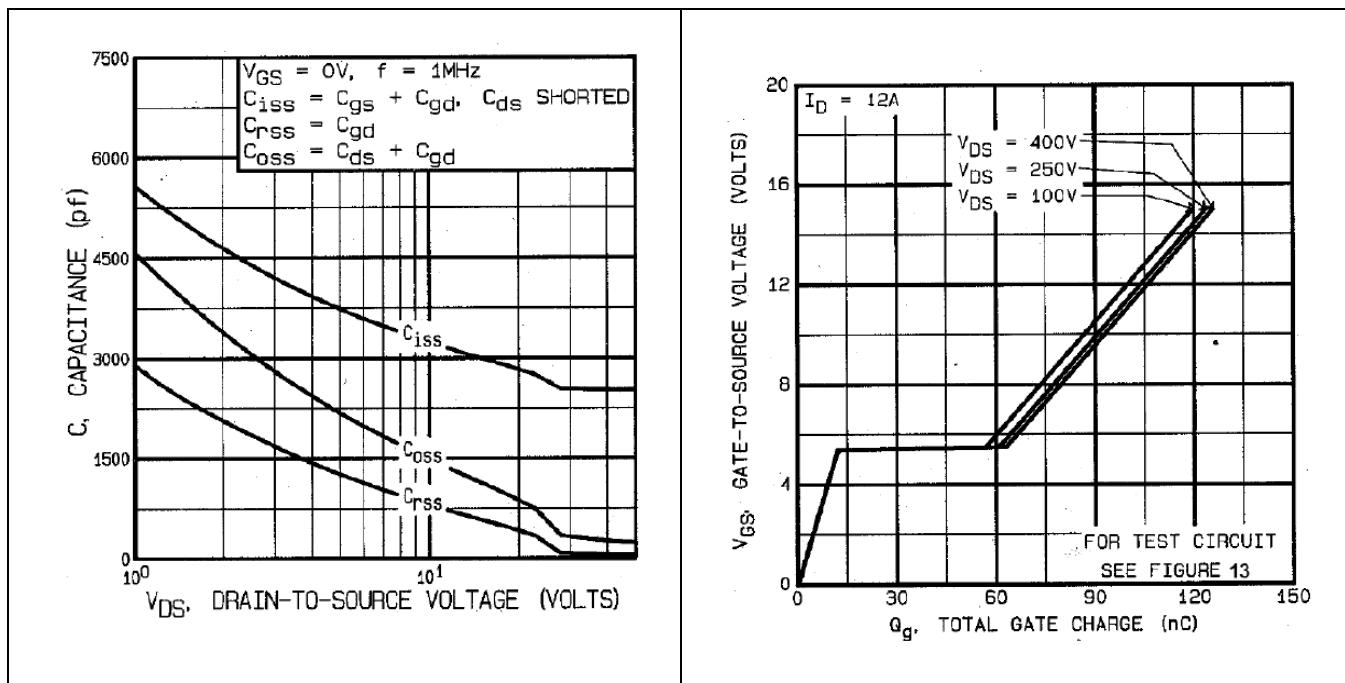
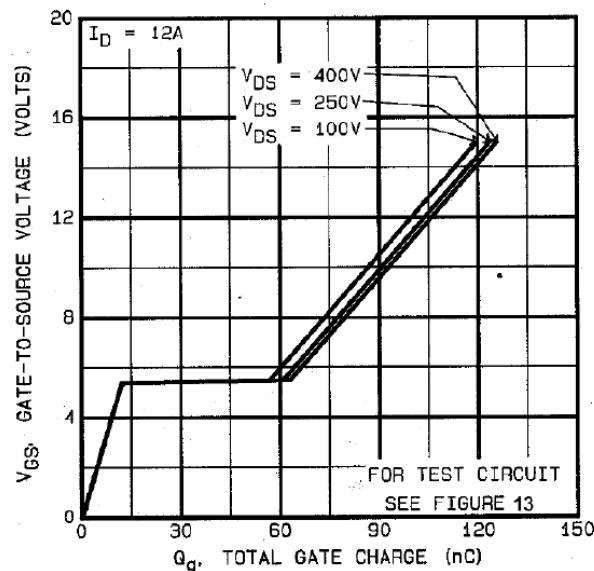


Figure 3 Typical Transfer Characteristics

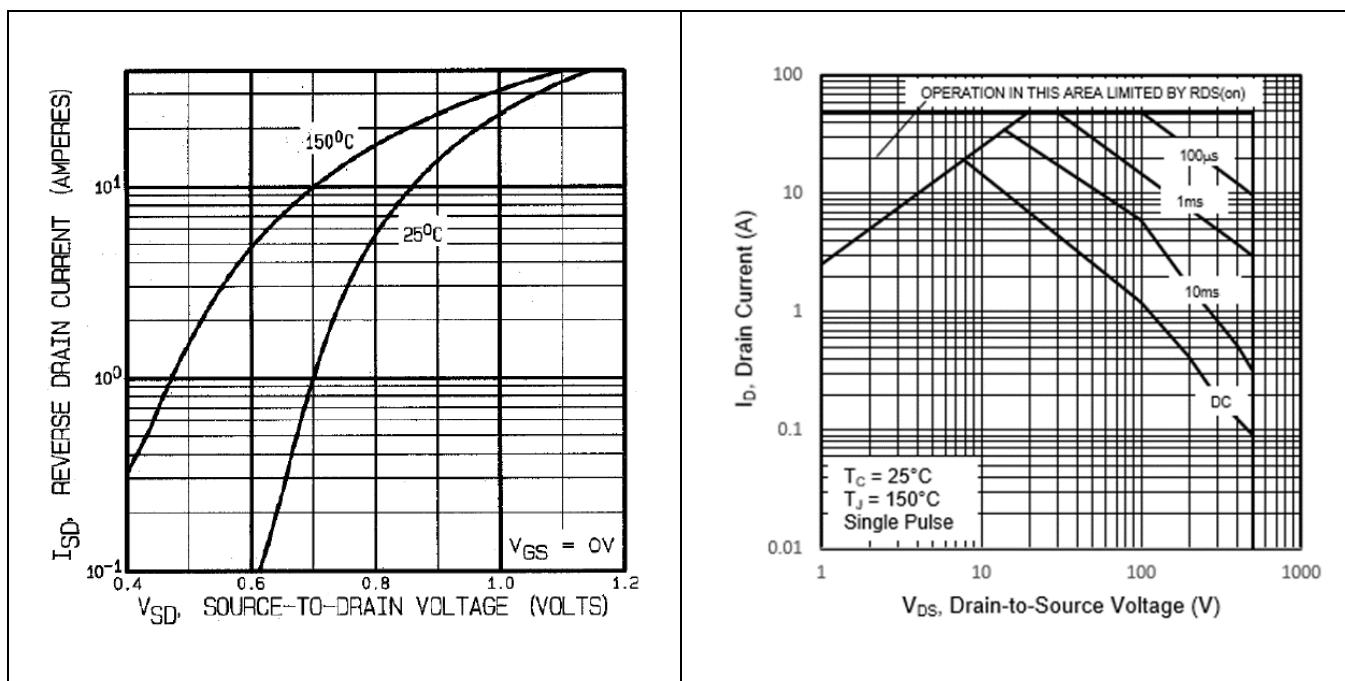
Figure 4 Normalized On-Resistance Vs. Temperature



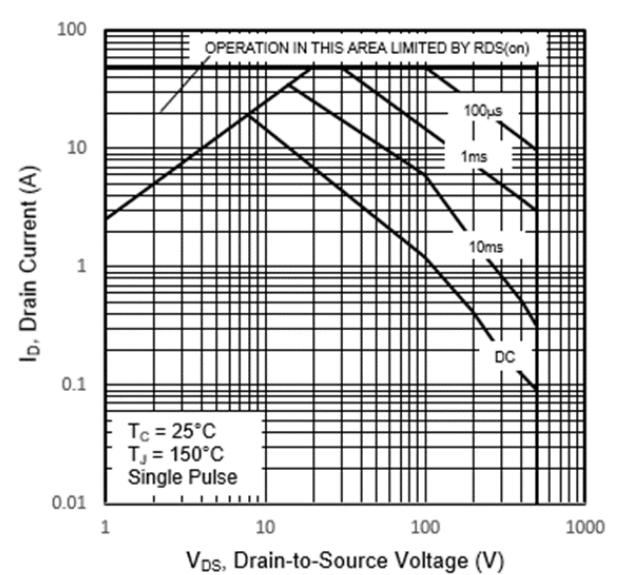
**Figure 5** Typical Capacitance Vs.  
Drain-to-Source Voltage



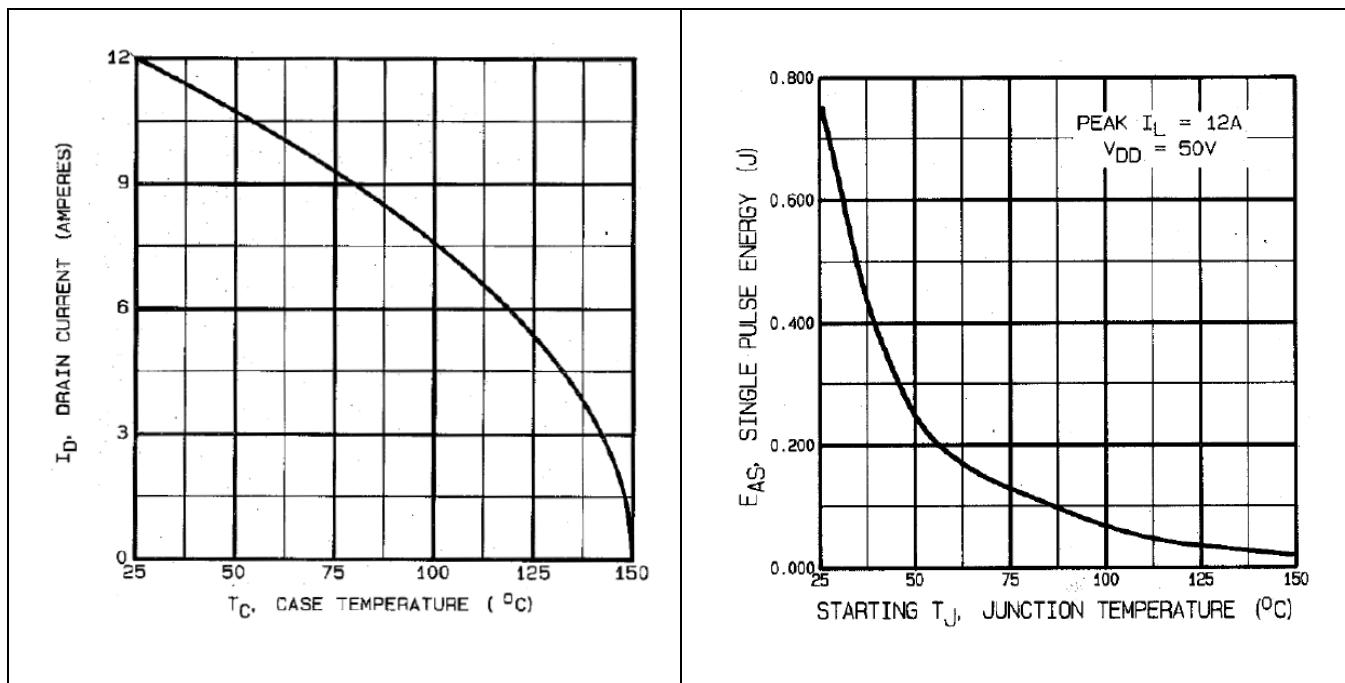
**Figure 6** Typical Gate Charge Vs.  
Gate-to-Source Voltage



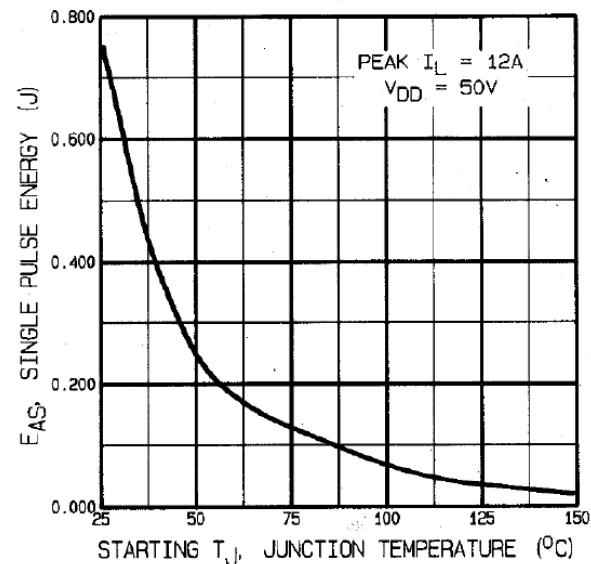
**Figure 7** Typical Source-Drain Current Vs.  
Diode Forward Voltage



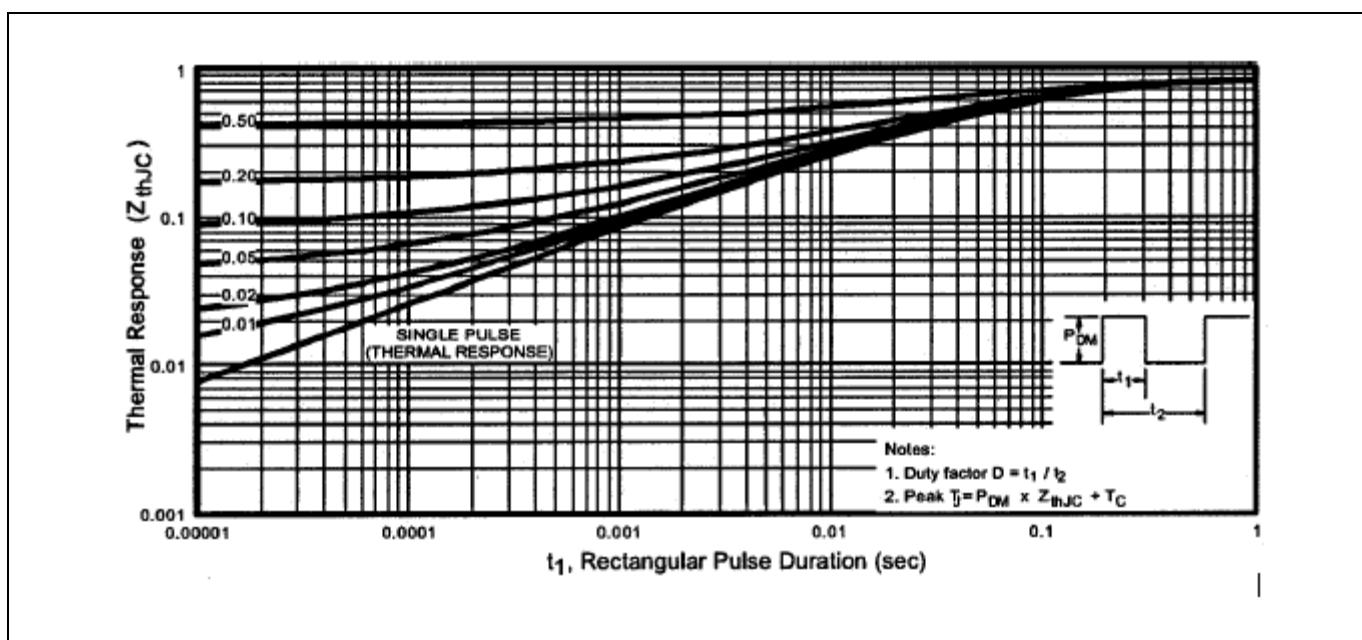
**Figure 8** Maximum Safe Operating Area



**Figure 9 Maximum Drain Current Vs.  
Case Temperature**



**Figure 10 Maximum Avalanche Energy Vs.  
Junction Temperature**



**Figure 11 Maximum Effective Transient Thermal Impedance, Junction-to-Case**

## Test Circuits

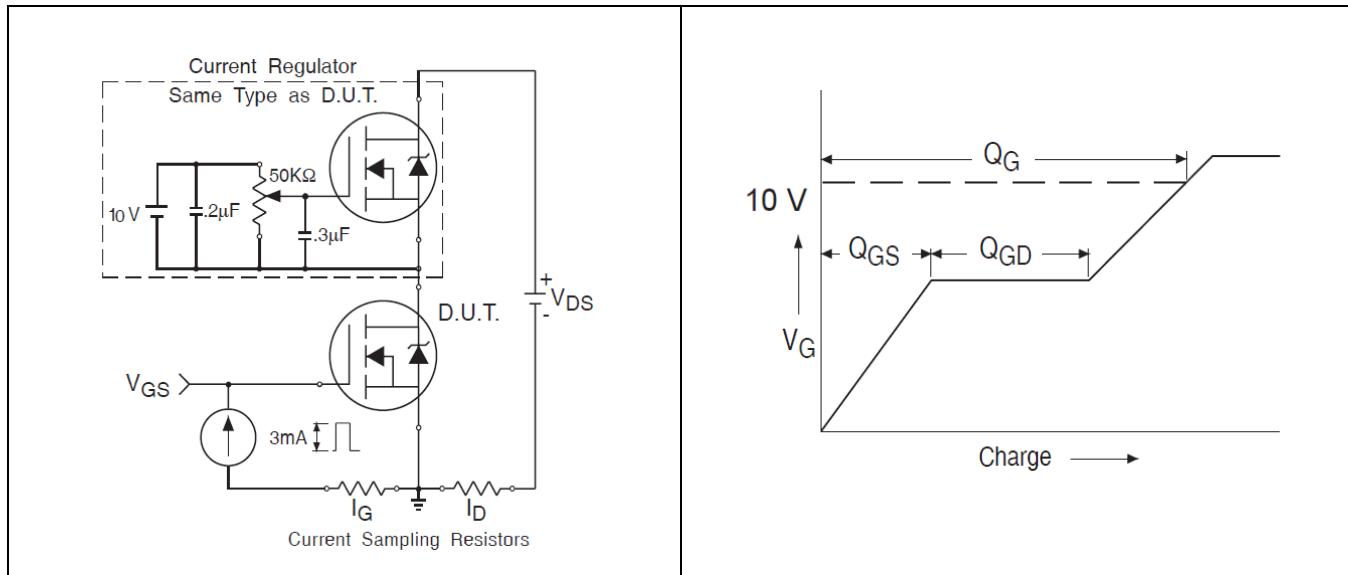
**4 Test Circuits**

Figure 12 Gate Charge Test Circuit

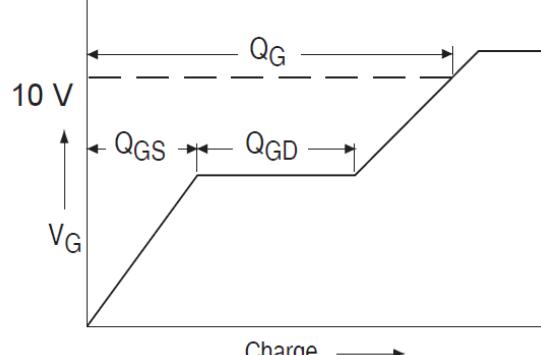


Figure 13 Gate Charge Waveform

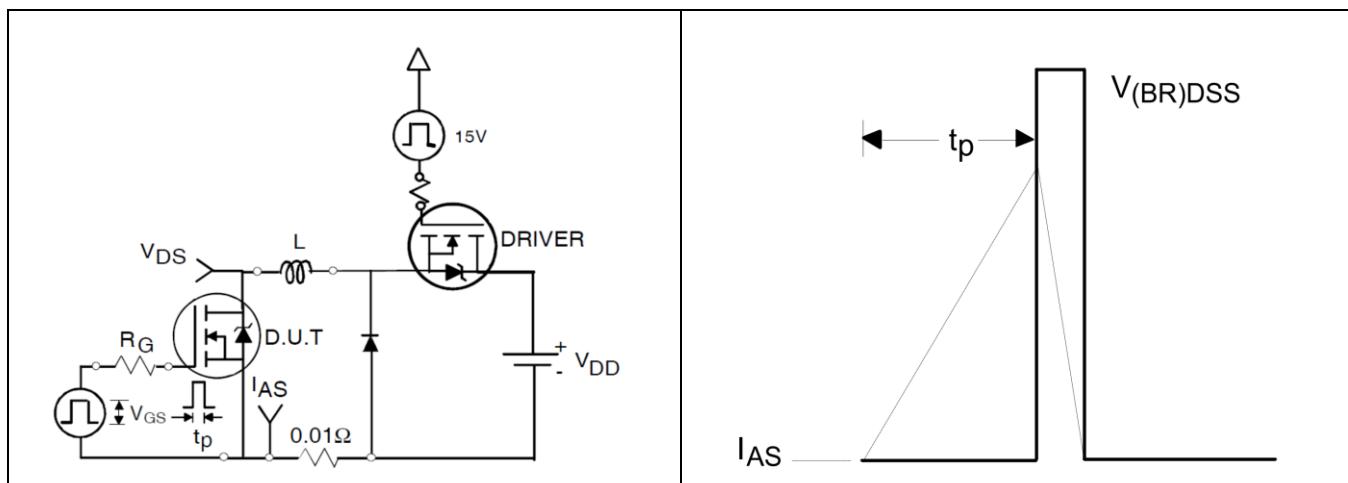


Figure 14 Unclamped Inductive Test Circuit

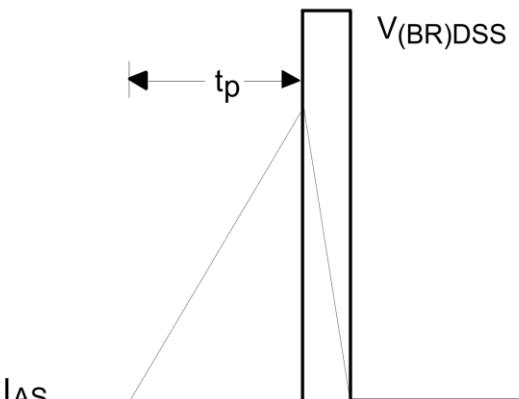


Figure 15 Unclamped Inductive Waveform

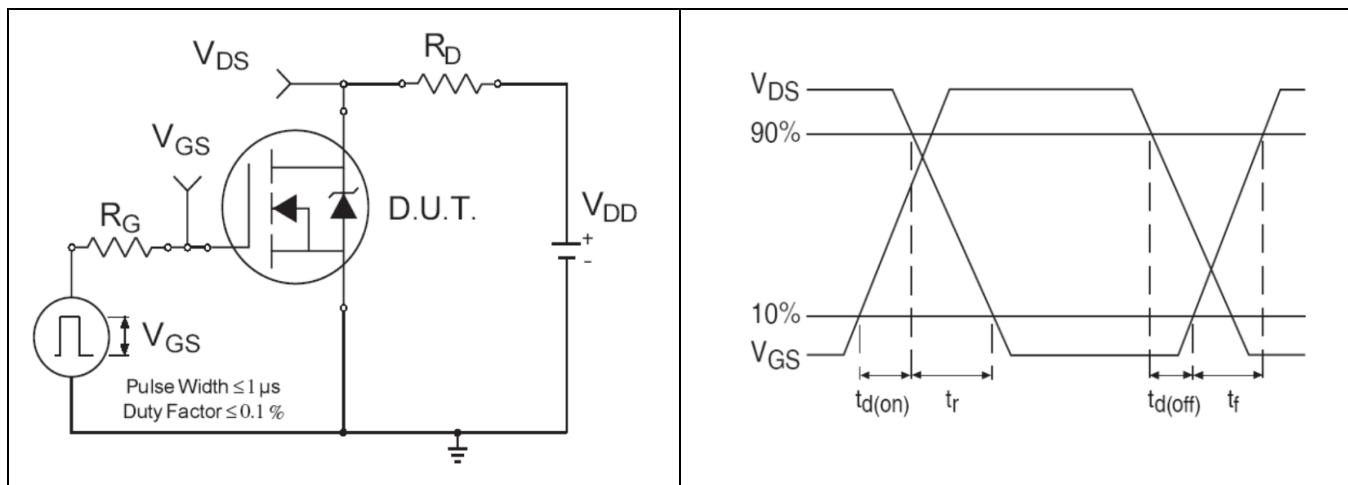


Figure 16 Switching Time Test Circuit

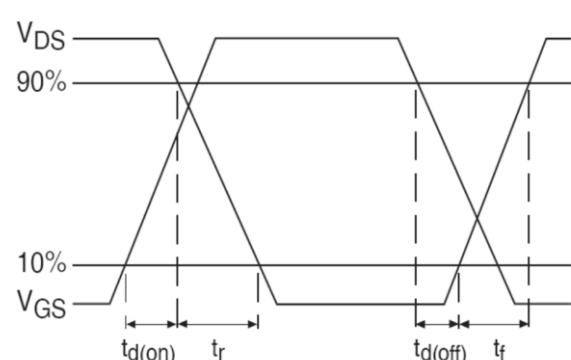
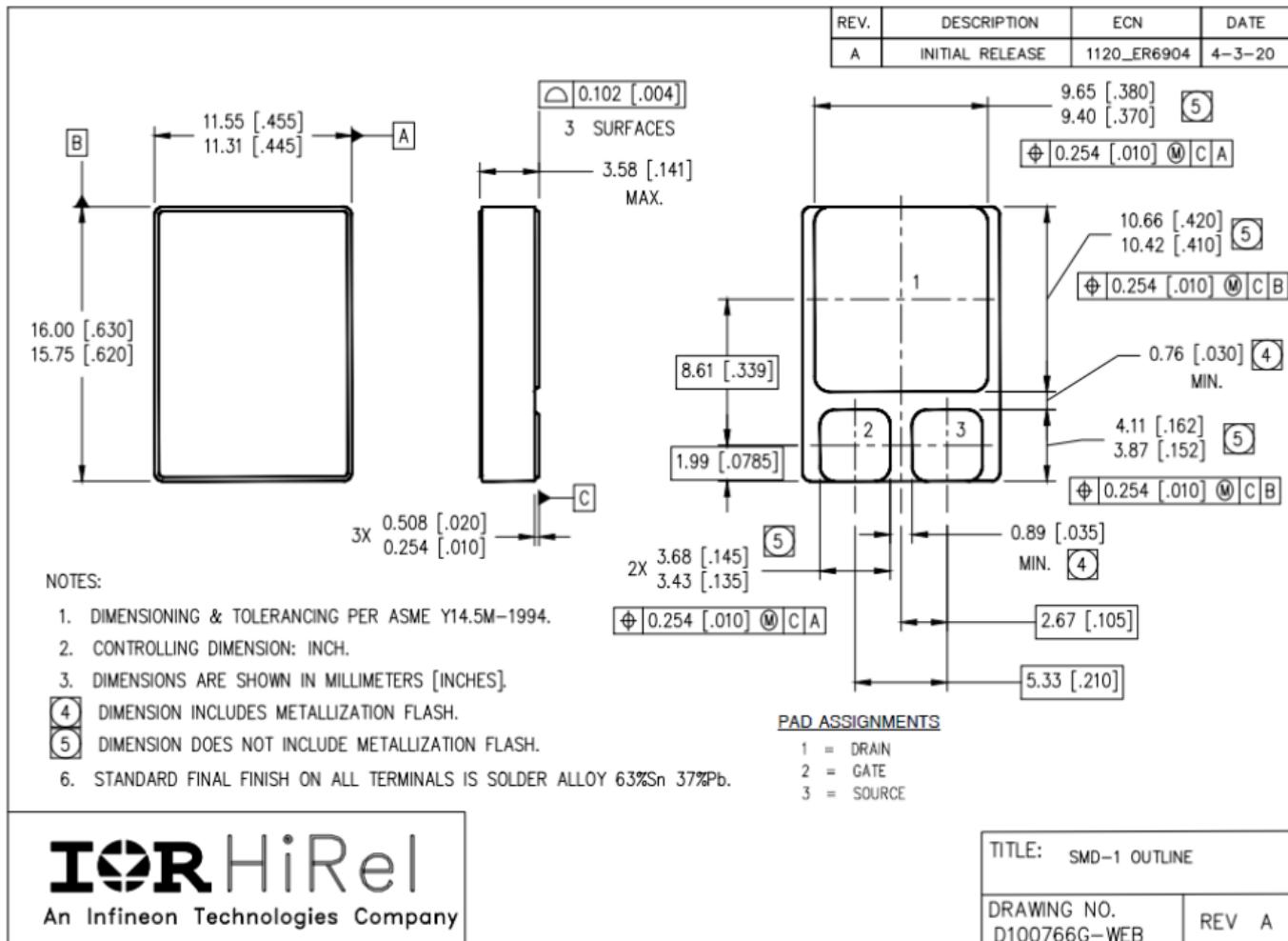


Figure 17 Switching Time Waveforms

## 5 Package Outline

Note: For the most updated package outline, please see the website: : [SMD-1](#)



**Revision history**

| <b>Document version</b> | <b>Date of release</b> | <b>Description of changes</b>              |
|-------------------------|------------------------|--|
| Rev A                   | 02/05/2002             | Datasheet (PD-90418)                       |
| Rev B                   | 06/16/2016             | Updated Rth-PCB                            |
| Rev C                   | 04/30/2021             | Updated Switch time test condition VGS=10V |
| Rev D                   | 08/06/2024             | Updated based on ECN-1120_10008            |

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